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Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/668,484	SHASTRI ET AL.	
Examiner	Art Unit	
David I Vanik	1615	

SEARCHED				
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INTERFERENCE SEARCHED				
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
East-See Attached	1/20/2006	DV
Inventor Search	1/20/2006	DV
Pubmed: See Attached	1/21/2006	DV
East der Attached	4/27/06	8K
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